

August 2007

FDMJ1023PZ

Dual P-Channel PowerTrench[®] MOSFET -20V, -2.9A, $112m\Omega$

Features

- Max $r_{DS(on)} = 112m\Omega$ at $V_{GS} = -4.5V$, $I_{D} = -2.9A$
- Max $r_{DS(on)} = 160 \text{m}\Omega$ at $V_{GS} = -2.5 \text{V}$, $I_D = -2.4 \text{A}$
- Max $r_{DS(on)} = 210m\Omega$ at $V_{GS} = -1.8V$, $I_D = -2.1A$
- Max $r_{DS(on)} = 300 m\Omega$ at $V_{GS} = -1.5 V$, $I_D = -1.0 A$
- Low gate charge, high power and current handling capability
- HBM ESD protection level > 1.5kV typical (Note 3)
- RoHS Compliant

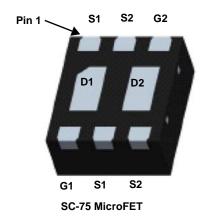


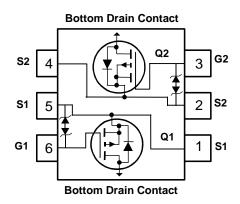
General Description

This dual P-Channel MOSFET uses Fairchild's advanced low voltage PowerTrench® process. This device is designed specifically as a single package solution for the battery charge switch in cellular handset and other ultra-portable applications. It features two independent P-Channel MOSFETs with low on-state resistance for minimum conduction losses. When connected in the typical common source configuration, bi-directional current flow is possible. The SC-75 MicroFET package offers exceptional thermal performance for its physical size and is well suited to linear mode applications.

Applications

■ Battery management/charger application





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DS}	Drain to Source Voltage		-20	V	
V _{GS}	Gate to Source Voltage		±8	V	
	Drain Current -Continuous	(Note 1a)	-2.9	^	
ID.	-Pulsed		-12	A	
Б	Power Dissipation	(Note 1a)	1.4	10/	
P_{D}	Power Dissipation	(Note 1b)	0.7	W	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	89	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	182	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
023	FDMJ1023PZ	SC-75 MicroFET	7"	8mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$, referenced to 25°C		-13		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16V, V_{GS} = 0V$			-1	μΑ
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8V$, $V_{DS} = 0V$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-0.4	-0.7	-1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$, referenced to 25°C		2.3		mV/°C
		$V_{GS} = -4.5V, I_D = -2.9A$		93	112	
		$V_{GS} = -2.5V, I_D = -2.4A$		128	160	
r _{DS(on)}	r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = -1.8V, I_D = -2.1A$		173	210	mΩ
		$V_{GS} = -1.5V, I_D = -1.0A$		217	300	
		$V_{GS} = -4.5V$, $I_D = -2.9A$, $T_J = 125$ °C		130	160	
9 _{FS}	Forward Transconductance	$V_{DD} = -5V, I_D = -2.9A$		7		S

Dynamic Characteristics

C _{iss}	Input Capacitance	10)/)/ 0)/	300	400	pF
C _{oss}	Output Capacitance	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1MHz	55	75	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1141112	45	70	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		5	10	ns
t _r	Rise Time	$V_{DD} = -10V, I_D = -2.9A$ $V_{GS} = -4.5V, R_{GEN} = 6\Omega$	4	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = -4.5V$, $N_{GEN} = 0.52$	23	37	ns
t _f	Fall Time		12	22	ns
Q_{g}	Total Gate Charge		4.6	6.5	nC
Q_{gs}	Gate to Source Charge	$V_{DD} = -5V, I_{D} = -2.9A$ $V_{GS} = -4.5V$	0.6		nC
Q_{gd}	Gate to Drain "Miller" Charge	VGS - 4.5V	1.0		nC

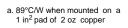
Drain-Source Diode Characteristics

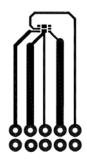
Is	Maximum Continuous Drain-Source Diode Forward Current				-1.1	Α
V_{SD}	Source to Drain Diode Forward Voltage $V_{GS} = 0V$, $I_S = -1.1A$			-0.9	-1.2	V
t _{rr}	Reverse Recovery Time	I _E = -2.9A, di/dt = 100A/μs		28	45	ns
Q _{rr}	Reverse Recovery Charge	$\frac{1}{1} = -2.9A$, $\frac{1}{1}$ $\frac{1}{$		15	27	nC

Notes:

^{1.} R_{BJA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{BJC} is guaranteed by design while R_{BJA} is determined by the user's board design.







b.182°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

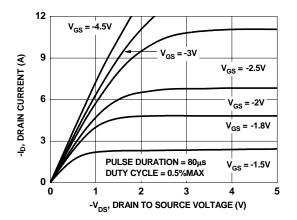


Figure 1. On-Region Characteristics

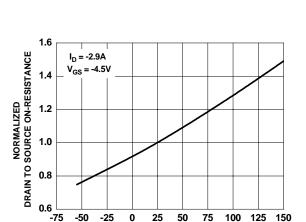


Figure 3. Normalized On-Resistance vs Junction Temperature

T_J, JUNCTION TEMPERATURE (°C)

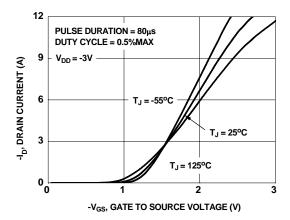


Figure 5. Transfer Characteristics

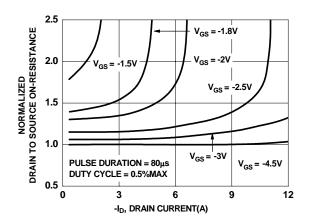


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

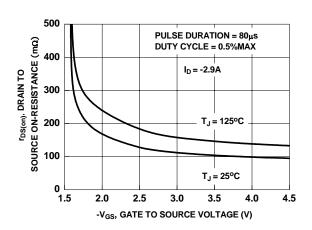


Figure 4. On-Resistance vs Gate to Source Voltage

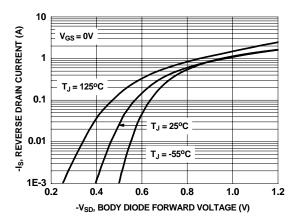


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

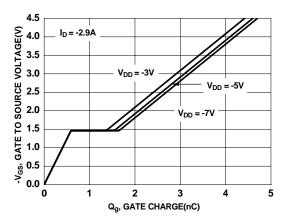


Figure 7. Gate Charge Characteristics

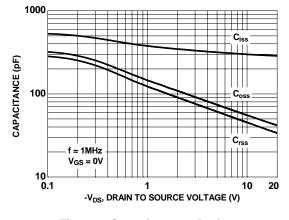


Figure 8. Capacitance vs Drain to Source Voltage

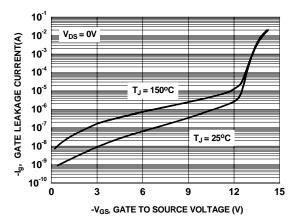


Figure 9. Gate Leakage Current vs Gate to Source Voltage

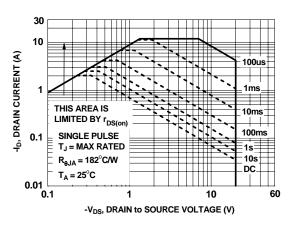


Figure 10. Forward Bias Safe Operating Area

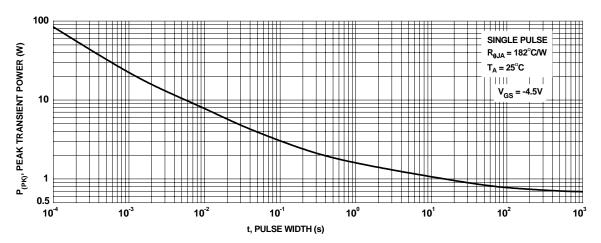


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

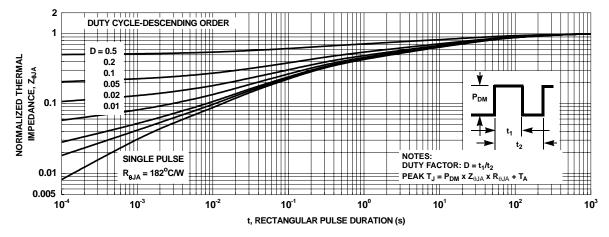
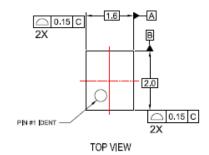
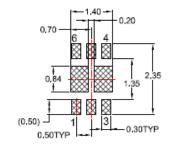


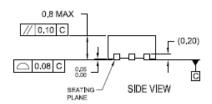
Figure 12. Transient Thermal Response Curve

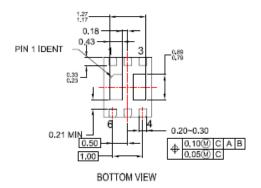
Dimensional Outline and Pad Layout





RECOMMENDED LAND PATTERN







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